PROCEEDINGS OF SPIE

Optics Frontier Online 2020: Optics Imaging and Display

Hannan Wang Editor

19-20 June 2020 Virtual Event

Organized by Chinese Laser Press (China)

Published by SPIE

Volume 11571

Proceedings of SPIE 0277-786X, V. 11571

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

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Author(s), "Title of Paper," in *Optics Frontier Online 2020: Optics Imaging and Display*, edited by Hannan Wang, Proceedings of SPIE Vol. 11571 (SPIE, Bellingham, WA, 2020) Seven-digit Article CID Number.

ISSN: 0277-786X ISSN: 1996-756X (electronic)

ISBN: 9781510639638 ISBN: 9781510639645 (electronic)

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